

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/712,153	TURNER ET AL.	
Examiner		Art Unit	Jennifer H. Gay	
		3672	Page 1 of 3	

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	B	US-6,302,216	10-2001	Patel, Dinesh R.	166/375
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